

Shenzhen Zhongjian Nanfang Testing Co., Ltd.

Report No: CCISE171000601

FCC REPORT

(GSM & WCDMA)

Applicant: Sun Cupid Technology (HK) Ltd.

Address of Applicant: 16/F, CEO Tower, 77 Wing Hong Street, Cheung Sha Wan,

Kowloon, Hong Kong.

Equipment Under Test (EUT)

Product Name: LTE mobile phone

Model No.: N5702L, G2, G3

Trade mark: NUU

FCC ID: 2ADINN5702L

FCC CFR Title 47 Part 2

Applicable standards: FCC CFR Title 47 Part 22 Subpart H

FCC CFR Title 47 Part 24 Subpart E

FCC CFR Title 47 Part 27 Subpart L

Date of sample receipt: 09 Oct., 2017

Date of Test: 09 Oct., to 03 Nov., 2017

Date of report issued: 06 Nov., 2017

Test Result: PASS*

* In the configuration tested, the EUT complied with the standards specified above.

Authorized Signature:



Bruce Zhang Laboratory Manager

This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product and does not permit the use of the CCIS product certification mark. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report.

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2. Version

Version No.	Date	Description
00	06 Nov., 2017	Original

Tested by: | CINCI Date: 06 Nov., 2017

Test Engineer

Reviewed by: 06 Nov., 2017

Project Engineer



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4. Test Summary

Test Item	Section in CFR 47	Result
RF Exposure (SAR)	Part 1.1307 Part 2.1093	Pass (Please refer to SAR Report)
RF Output Power	Part 2.1046 Part 22.913 (a)(2) Part 24.232 (c) Part 27.50 (d)(4)	Pass
Peak-to-Average Power Ratio	Part 24.232 (d) Part 27.50 (d)(5)	Pass
Modulation Characteristics	Part 2.1047	Pass
99% & -26 dB Occupied Bandwidth	Part 2.1049 Part 22.917(b) Part 24.238(b) Part 27.53(h)	Pass
Spurious Emissions at Antenna Terminal	Part 2.1051 Part 22.917 (a) Part 24.238 (a) Part 27.53 (h)	Pass
Field Strength of Spurious Radiation	Part 2.1053 Part 22.917 (a) Part 24.238 (a) Part 27.53 (h)	Pass
Out of band emission, Band Edge	Part 22.917 (a) Part 24.238 (a) Part 27.53 (h)	Pass
Frequency stability vs. temperature	Part 22.355 Part 24.235 Part 27.54 Part 2.1055(a)(1)(b)	Pass
Frequency stability vs. voltage	Part 22.355 Part 24.235 Part 27.54 Part 2.1055(d)(2)	Pass





5. General Information

5.1 Client Information

Applicant:	Sun Cupid Technology (HK) Ltd.
Address:	16/F, CEO Tower, 77 Wing Hong Street, Cheung Sha Wan, Kowloon, Hong Kong.
Manufacturer	Sun Cupid Technology (HK) Ltd.
Address:	16/F, CEO Tower, 77 Wing Hong Street, Cheung Sha Wan, Kowloon, Hong Kong.
Factory:	SUNCUPID (ShenZhen) Electronic Ltd
Address:	Baolong Industrial City, Longgang District, Shenzhen Hi-Tech Road, Building 1, A 7, China.

5.2 General Description of E.U.T.

Product Name:	LTE mobile phone
Model No.:	N5702L,G2, G3
Operation Frequency range:	GSM 850: 824.20MHz-848.80MHz
	PCS1900: 1850.20MHz-1909.80MHz
	WCDMA Band V: 826.4MHz-846.6MHz
	WCDMA Band II: 1852.4 MHz -1907.6 MHz
	WCDMA Band IV: 1712.4 MHz -1752.6 MHz
Modulation type:	GSM/GPRS:GMSK, UMTS:QPSK, EGPRS: 8PSK
Antenna type:	Internal Antenna
Antenna gain:	GSM 850: -3.54 dBi
	PCS 1900: -2.60 dBi
	WCDMA Band V: -3.54 dBi
	WCDMA Band II: -2.60 dBi
	WCDMA Band IV: -2.91 dBi
Power supply:	Rechargeable Li-ion Battery DC3.8V-3000mAh
AC adapter with two plugs :	Model: HNEM050200UU
	Input: AC100-240V, 50/60Hz, 0.35A
	Output: DC 5.0V, 2000mA
Remark:	Model No.: N5702L, G2, G3 were identical inside, the electrical circuit design, layout, components used and internal wiring, with only difference being model name.





Operation Frequency List:	Operation Frequency List:				
GS	SM 850	PC	PCS1900		
Channel:	Frequency (MHz)	Channel:	Frequency (MHz)		
128	824.20	512	1850.20		
129	824.40	513	1850.40		
189	836.40	660	1879.80		
190	836.60	661	1880.00		
191	836.80	662	1880.20		
250	848.60	809	1909.60		
251	848.80	810	1909.80		
WCDI	MA Band V	WCDI	MA Band II		
Channel:	Frequency (MHz)	Channel:	Frequency (MHz)		
4132	826.40	9262	1852.40		
4133	826.60	9263	1852.60		
4182	836.40	9399	1879.80		
4183	836.60	9400	1880.00		
4184	836.80	9401	1880.20		
4232	846.40	9537	1907.40		
4233	846.60	9538	1907.60		
	//A Band IV				
Channel:	Frequency (MHz)				
1312	1712.40	_			
1313	1712.60				
1412	1732.40				
1413	1732.60				
1414	1732.80				
1512	1752.40				

Regards to the operating frequency range over 10 MHz, the Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, and the selected channel see below:

1752.60

1513





GSM850			PCS1900		
Channel		Frequency(MHz)	Channel		Frequency(MHz)
Lowest channel	128	824.20	Lowest channel	512	1850.20
Middle channel	190	836.60	Middle channel	661	1880.00
Highest channel	251	848.80	Highest channel	810	1909.80
V	VCDMA Band	IV	,	WCDMA Ban	id II
Channe	I	Frequency(MHz)	Channel		Frequency(MHz)
Lowest channel	4132	826.40	Lowest channel	Lowest channel 9262	
Middle channel	4183	836.60	Middle channel	9400	1880.00
Highest channel	Highest channel 4233		Highest channel	9538	1907.60
WCDMA Band IV					
Channel		Frequency(MHz)			
Lowest channel 1312		1712.40			
Middle channel 1413		1732.60			
Highest channel 1513		1752.60	1		

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5.3 Test modes

Operating Environmen	Operating Environment:			
Temperature:	Normal: 15℃ ~ 35℃, Extreme: -30℃ ~ +50℃			
Humidity:	20 % ~ 75 % RH			
Atmospheric Pressure:	1008 mbar			
Voltage:	Nominal: 3.8Vdc, Extreme: Low 3.5 Vdc, High 4.35 Vdc			
Test mode:				
GSM mode	Keep the EUT communication with simulated station in GSM mode			
GPRS mode	Keep the EUT communication with simulated station in GPRS mode			
EGPRS mode	Keep the EUT communication with simulated station in EGPRS mode			
RMC mode	Keep the EUT communication with simulated station in RMC mode			
HSDPA	Keep the EUT communication with simulated station in HSDPA mode			
HSUPA	Keep the EUT communication with simulated station in HSUPA mode			

Remark: The EUT has been tested under continuous transmitting mode. Channel Low, Mid and High for each type band with rated data rate were chosen for full testing. The field strength of spurious radiation emission was measured as EUT stand-up position (H mode) and lie down position (E1, E2 mode) for these modes with power adaptor, earphone and Data cable. Just the worst case position (H mode) shown in report.

5.4 Description of Support Units

Test Equipment	Manufacturer	Model No.	Serial No.
Simulated Station	Anritsu	MT8820C	6201026545

5.5 Measurement Uncertainty

Parameters	Expanded Uncertainty
Radiated Emission (9kHz ~ 30MHz)	4.24 dB (k=2)
Radiated Emission (30MHz ~ 1000MHz)	4.35 dB (k=2)
Radiated Emission (1GHz ~ 18GHz)	4.44 dB (k=2)
Radiated Emission (18GHz ~ 26.5GHz)	4.56 dB (k=2)
Radiated Emission (18GHz ~ 26.5GHz)	4.56 dB (k=2)

5.6 Laboratory Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC - Registration No.: 727551

Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been accredited as a testing laboratory by FCC (Federal Communications Commission). The Registration No. is 727551.

IC - Registration No.: 10106A-1

The 3m Semi-anechoic chamber of Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been Registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 10106A-1.

CNAS - Registration No.: CNAS L6048

Shenzhen Zhongjian Nanfang Testing Co., Ltd. is accredited to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration laboratories for the competence of testing. The Registration No. is CNAS L6048.

A2LA - Registration No.: 4346.01

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 General requirements for the competence of testing and calibration laboratories. The test scope can be found as below link: https://portal.a2la.org/scopepdf/4346-01.pdf

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5.7 Laboratory Location

Shenzhen Zhongjian Nanfang Testing Co., Ltd.

Address: No. B-C, 1/F., Building 2, Laodong No.2 Industrial Park, Xixiang Road,

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Email: info@ccis-cb.com, Website: http://www.ccis-cb.com

5.8 Test Instruments list

Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)
3m SAC	SAEMC	9m*6m*6m	966	07-22-2017	07-21-2020
BiConiLog Antenna	SCHWARZBECK	VULB9163	497	02-25-2017	02-24-2018
Biconical Antenna	SCHWARZBECK	VUBA9117	359	06-22-2017	06-21-2018
Horn Antenna	SCHWARZBECK	BBHA9120D	916	02-25-2017	02-24-2018
Horn Antenna	SCHWARZBECK	BBHA9120D	1805	02-25-2017	02-24-2018
EMI Test Software	AUDIX	E3	6.110919b	N/A	N/A
Pre-amplifier	HP	8447D	2944A09358	02-25-2017	02-24-2018
Pre-amplifier	CD	PAP-1G18	11804	02-25-2017	02-24-2018
Spectrum analyzer	Rohde & Schwarz	FSP30	101454	02-25-2017	02-24-2018
EMI Test Receiver	Rohde & Schwarz	ESRP7	101070	02-25-2017	02-24-2018
Spectrum Analyzer	Agilent	N9020A	MY50510123	10-29-2017	10-28- 2018
Signal Generator	Rohde & Schwarz	SMX	835454/016	02-25-2017	02-24- 2018
Signal Generator	R&S	SMR20	1008100050	02-25-2017	02-24-2018
RF Switch Unit	MWRFTEST	MW200	N/A	N/A	N/A
Cable	ZDECL	Z108-NJ-NJ-81	1608458	02-25-2017	02-24-2018
Cable	MICRO-COAX	MFR64639	K10742-5	02-25-2017	02-24-2018
Cable	SUHNER	SUCOFLEX100	58193/4PE	02-25-2017	02-24-2018
DC Power Supply	XinNuoEr	WYK-10020K	1409050110020	10-31-2017	10-30-2018
Temperature Humidity Chamber	HengPu	HPGDS-500	20140828008	09-24-2017	09-23-2018
Simulated Station	Rohde & Schwarz	CMW500	140493	06-24-2017	06-23-2018



6. Test results

6.1 Conducted Output Power

T			
Test Requirement:	FCC part 22.913(a)(2), FCC part 24.232(c) and FCC part 27.50(d)(4)		
Test Method:	ANSI/TIA-603-D 2010		
Limit:	GSM 850: 7W, PCS 1900: 2W		
	WCDMA Band V: 7W, WCDMA Band II: 2W, WCDMA Band IV: 1W		
Test setup:	System simulator ATT EUT		
Test Procedure:	The transmitter output was connected to a calibrated attenuator, the other end of which was connected to the simulated station. Transmitter output power was read off in dBm.		
Test Instruments:	Refer to section 5.8 for details		
Test mode:	Refer to section 5.3 for details		
Test results:	Passed		





Measurement Data:

Measurement Data:				
	Bur			
EUT Mode	128	190	251	Limit(dBm)
	824.20MHz	836.60MHz	848.80MHz	
GSM 850	32.40	32.41	32.38	
GPRS 850 (1 Uplink slot)	32.29	32.29	32.26	
GPRS 850 (2 Uplink slot)	31.48	31.49	31.48	
GPRS 850 (3 Uplink slot)	29.69	29.72	29.72	
GPRS 850 (4 Uplink slot)	28.55	25.58	25.59	38.45
EGPRS 850 (1 Uplink slot)	26.96	26.85	26.66	
EGPRS 850 (2 Uplink slot)	25.90	25.78	25.61	
EGPRS 850 (3 Uplink slot)	24.06	23.94	23.73	
EGPRS 850 (4 Uplink slot)	22.95	22.89	22.71	
	Bur			
EUT Mode	512	661	810	Limit(dBm)
	1850.20MHz	1880.00MHz	1909.80MHz	
PCS 1900	29.37	29.37	29.45	
GPRS 1900 (1 Uplink slot)	29.36	29.34	29.41	
GPRS 1900 (2 Uplink slot)	28.59	28.61	28.66	
GPRS 1900 (3 Uplink slot)	26.89	26.90	26.96	
GPRS 1900 (4 Uplink slot)	25.81	25.82	25.87	33.00
EGPRS 1900 (1 Uplink slot)	25.74	25.66	25.32	
EGPRS 1900 (2 Uplink slot)	24.56	24.49	24.15	
EGPRS 1900 (3 Uplink slot)	22.60	22.61	22.35	
EGPRS 1900 (4 Uplink slot)	21.47	21.49	21.17	





		Burst	Average power (di	3m)	
EUT Mode		4132	4183	4233	Limit(dBm)
		826.40MHz	836.60MHz	846.60MHz	
	Subtest 1	22.10	22.07	22.10	
UMTS 850	Subtest 2	21.74	21.84	21.60	
HSDPA	Subtest 3	20.13	20.21	20.02	
	Subtest 4	20.11	20.34	20.22	
	Subtest 1	21.94	22.07	21.78	
	Subtest 2	21.97	22.08	21.88	38.45
UMTS 850 HSUPA	Subtest 3	20.09	20.24	20.10	
TISOFA	Subtest 4	22.07	22.06	22.06	
	Subtest 5	21.08	21.22	21.00	
UMTS 850 RMC	12.2kbps	23.07	23.12	23.08	
UMTS 850 AMR	12.2kbps	23.02	23.03	23.05	
		Burst	Average power (dl	Bm)	
EUT Mo	ode	9262	9400	9538	Limit(dBm)
		1852.40MHz	1880.00MHz	1907.60MHz	
	Subtest 1	21.55	21.48	21.61	
UMTS 1900	Subtest 2	21.17	21.10	21.22	
HSDPA	Subtest 3	19.72	19.62	19.73	
	Subtest 4	19.79	19.60	19.54	
	Subtest 1	21.46	21.43	21.51	
LINATO 4000	Subtest 2	21.47	21.44	21.54	33.00
UMTS 1900 HSUPA	Subtest 3	19.72	19.61	19.83	
1100171	Subtest 4	21.56	21.49	21.57	
	Subtest 5	20.55	20.52	20.72	
UMTS 1900 RMC	12.2kbps	22.54	22.48	22.53	
UMTS 1900 AMR	12.2kbps	22.50	22.44	22.49	
		Burst Average power (dBm)			
EUT Mo	ode	1312	1412	1513	Limit(dBm)
		1712.40MHz	1732.40MHz	1752.60MHz	
	Subtest 1	22.53	22.52	22.52	
UMTS 1700	Subtest 2	22.25	22.26	22.19	
HSDPA	Subtest 3	20.57	20.75	20.68	
	Subtest 4	20.71	20.75	20.77	
	Subtest 1	22.04	22.00	21.96	
	Subtest 2	22.07	21.95	22.00	33.00
UMTS 1700 HSUPA	Subtest 3	20.06	20.30	20.10	
ПЭПА	Subtest 4	22.10	22.03	22.01	
	Subtest 5	21.24	21.12	21.16	
UMTS 1700 RMC	12.2kbps	23.09	23.05	23.10	
UMTS 1700 AMR	12.2kbps	23.08	23.04	23.06	





6.2 Occupy Bandwidth

Test Requirement:	FCC part 22.917(b), FCC part 24.238(b) and FCC Part 27.53(h)
Test Method:	ANSI/TIA-603-D 2010
Test setup:	System simulator Splitter ATT EUT Spectrum Analyzer
Test Procedure:	 The EUT's output RF connector was connected with a short cable to the spectrum analyzer RBW was set to about 1% of emission BW, VBW= 3 times RBW. -26dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace.
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed





Measurement Data:

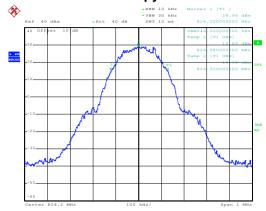
EUT Mode	Channel	Frequency (MHz)	99% Occupy bandwidth (kHz)	-26dB bandwidth (kHz)
	128	824.2	246	322
GSM 850	190	836.6	246	318
	251	848.8	248	316
	128	824.2	252	322
EGPRS850	190	836.6	248	314
	251	848.8	256	318
	512	1850.2	252	324
PCS 1900	661	1880.0	252	320
	810	1909.8	246	316
	512	1850.2	256	316
EGPRS1900	661	1880.0	254	322
	810	1909.8	256	316
LIMTO	4132	826.4	4180	4680
UMTS 850 12.2k RMC	4183	836.6	4160	4700
12.2K KIVIC	4233	846.6	4160	4700
UMTS 1900 12.2k RMC	9262	1852.4	4180	4700
	9400	1880.0	4160	4680
	9538	1907.6	4160	4720
UMTS 1700 12.2k RMC	1312	1712.40	4200	4680
	1413	1732.60	4160	4700
	1513	1752.60	4180	4680

Note: GSM & GPRS use the same modulation technical (GMSK), and with the same channels, so the 99% OBW and the -26dB of GPRS not performed.



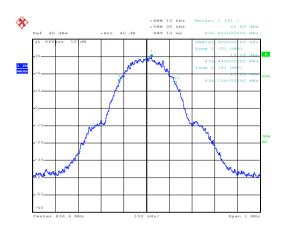
Test plot as follows:

99% Occupy bandwidth



Date: 16.0CT.2017 09:19:17

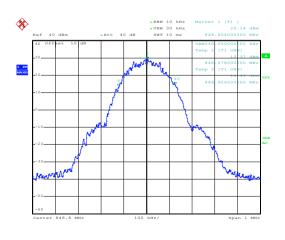
Lowest channel



Date: 16.0CT.2017 09:21:15

Date: 16.0CT.2017 09:21:39

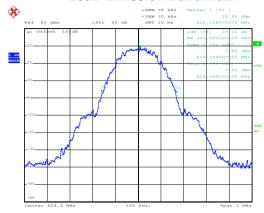
Middle channel



Highest channel

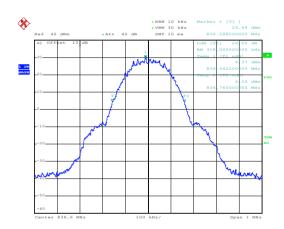
GSM 850

26dB Emission Bandwidth



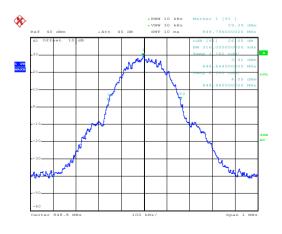
Date: 16.0CT.2017 09:19:55

Lowest channel



Date: 16.0CT.2017 09:20:37

Middle channel



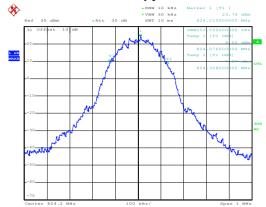
Date: 16.0CT.2017 09:21:55

Highest channel



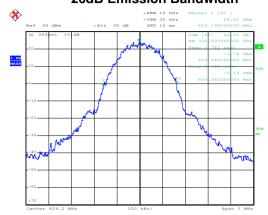
EGPRS 850

99% Occupy bandwidth



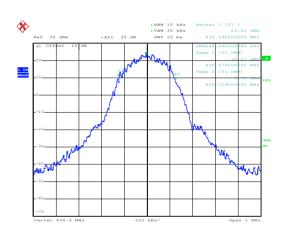
Date: 16.OCT.2017 09:23:59

26dB Emission Bandwidth



Date: 16.0CT.2017 09:23:39

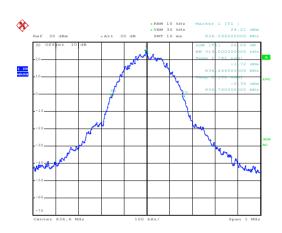
Lowest channel



Date: 16.0CT.2017 09:24:22

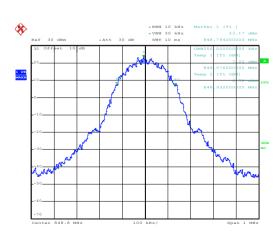
Date: 16.0CT.2017 09:25:19

Lowest channel



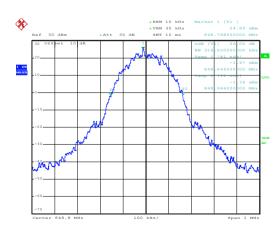
Date: 16.0CT.2017 09:24:41

Middle channel



Highest channel

Middle channel



Date: 16.OCT.2017 09:25:03

Highest channel

Shenzhen Zhongjian Nanfang Testing Co., Ltd.
No. B-C, 1/F., Building 2, Laodong No.2 Industrial Park, Xixiang Road, Bao'an District, Shenzhen, Guangdong, China
Telephone: +86 (0) 755 23118282 Fax: +86 (0) 755 23116366

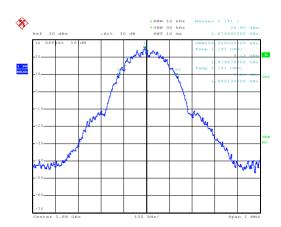


99% Occupy bandwidth



Date: 16.0CT.2017 09:32:00

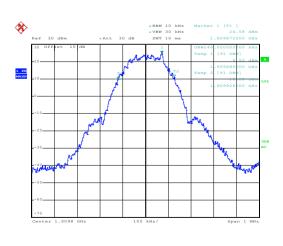
Lowest channel



Date: 16.0CT.2017 09:32:16

Date: 16.0CT.2017 09:33:03

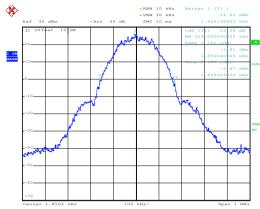
Middle channel



Highest channel

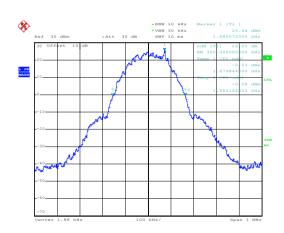
PCS 1900

26dB Emission Bandwidth



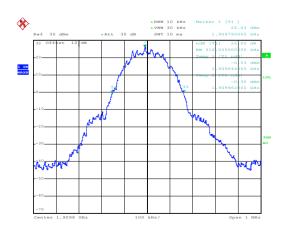
Date: 16.0CT.2017 09:31:48

Lowest channel



Date: 16.0CT.2017 09:32:32

Middle channel



Date: 16.0CT.2017 09:32:51

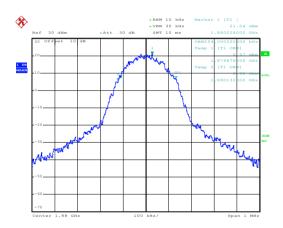
Highest channel



EGPRS I

Date: 16.0CT.2017 09:28:43

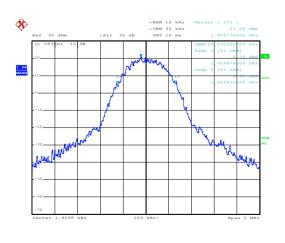
Lowest channel



Date: 16.OCT.2017 09:29:34

Date: 16.OCT.2017 09:29:56

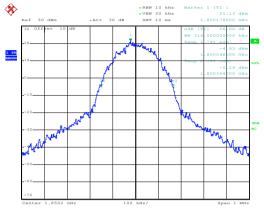
Middle channel



Highest channel

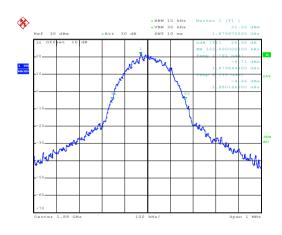
EGPRS 1900

26dB Emission Bandwidth



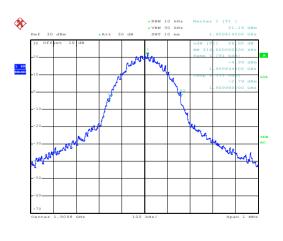
Date: 16.0CT.2017 09:28:58

Lowest channel



Date: 16.0CT.2017 09:29:19

Middle channel



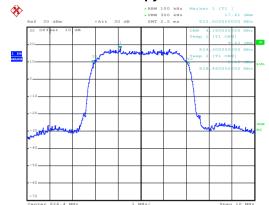
Date: 16.0CT.2017 09:30:09

Highest channel



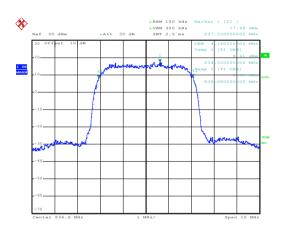
UMTS 850 12.2k RMC

99% Occupy bandwidth



Date: 16.0CT.2017 09:41:04

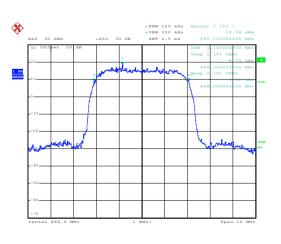
Lowest channel



Date: 16.0CT.2017 09:41:51

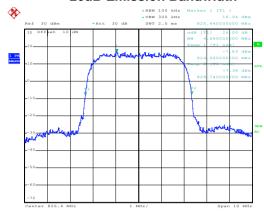
Date: 16.OCT.2017 09:42:08

Middle channel



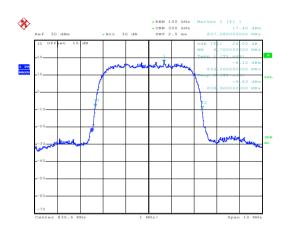
Highest channel

26dB Emission Bandwidth



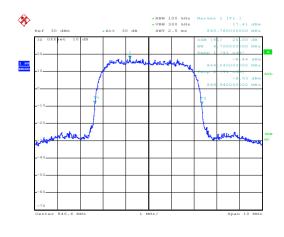
Date: 16.0CT.2017 09:41:13

Lowest channel



Date: 16.0CT.2017 09:41:38

Middle channel



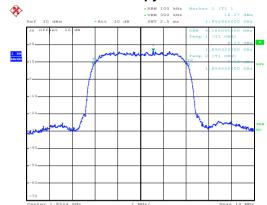
Date: 16.0CT.2017 09:42:18

Highest channel



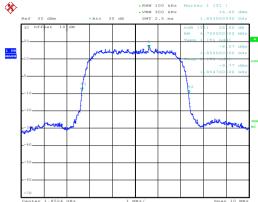
UMTS 1900 12.2k RMC

99% Occupy bandwidth



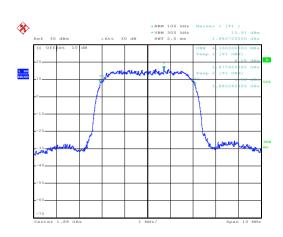
Date: 16.OCT.2017 09:35:16

26dB Emission Bandwidth *RBW 100 kHx Marker 1 [T1]



Date: 16.0CT.2017 09:35:30

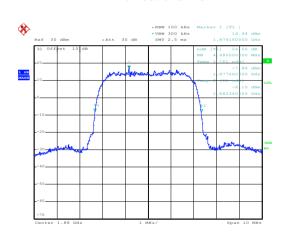
Lowest channel



Date: 16.0CT.2017 09:36:09

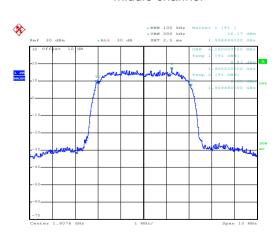
Date: 16.0CT.2017 09:36:34

Lowest channel



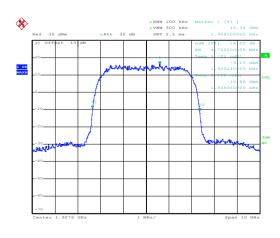
Date: 16.0CT.2017 09:35:55

Middle channel



Highest channel

Middle channel



Date: 16.0CT.2017 09:36:46

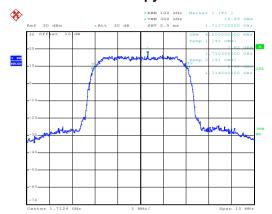
Highest channel

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Bao'an District, Shenzhen, Guangdong, China
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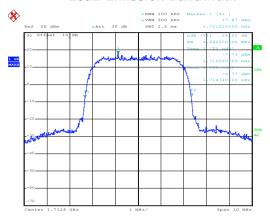


UMTS 1700 12.2k RMC

99% Occupy bandwidth

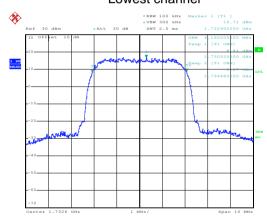


26dB Emission Bandwidth



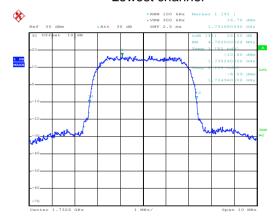
Date: 16.OCT.2017 09:37:36

Lowest channel



Date: 16.0CT.2017 09:37:24

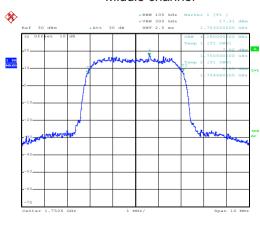
Lowest channel



Date: 16.0CT.2017 09:39:38

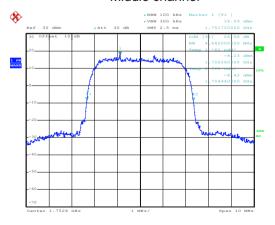
Date: 16.0CT.2017 09:40:26

Middle channel



Date: 16.0CT.2017 09:39:48

Middle channel



Date: 16.0CT.2017 09:40:16

Highest channel

Highest channel



6.3 Peak-to-Average Power Ratio

Test Requirement:	FCC part 24.232(d), FCC part 27.50(d)(5)	
Test Method	ANSI/TIA-603-D 2010	
Limit:	The peak-to-average ratio (PAR) of the transmission may not exceed 13 dB.	
Test setup:		
Test Procedure:	 The RF output of the transceiver was connected to a spectrum analyzer through appropriate attenuation. Set the CCDF option in spectrum analyzer, RBW ≥ OBW, Set the EUT working in highest power level, measured and recorded the 0.1% as PAPR level. Repeat step 1~3 at other frequency and modulations. 	
Test Instruments:	Refer to section 5.8 for details	
Test mode:	Refer to section 5.3 for details	
Test results:	Passed	

Measurement Data:

Modulation	Test channel	PAPR
GSM 850	190	0.10
EGPRS 850	190	0.10
PCS 1900	661	0.53
EGPRS 1900	661	0.30
UMTS 850 RMC	4183	3.00
UMTS 1900 RMC	9400	3.04
UMTS1700 RMC	1413	3.16





Test plots as below:

Middle channel

GSM 850



Date: 16.0CT.2017 10:07:32

Middle channel

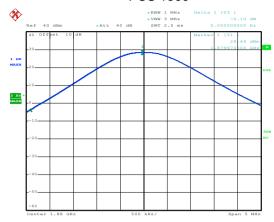
EGPRS 850



Date: 16.0CT.2017 10:04:56

Middle channel

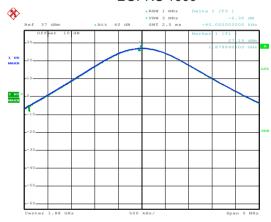
PCS 1900



Date: 16.0CT.2017 10:12:48

Middle channel

EGPRS 1900

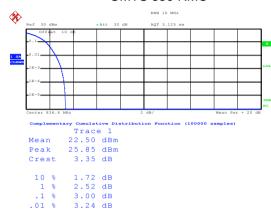


Date: 16.0CT.2017 11:22:34



Middle channel

UMTS 850 RMC



Date: 16.0CT.2017 09:55:33

Middle channel

UMTS1700 RMC



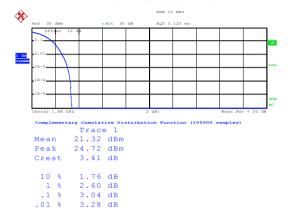
Complementary Countitative Disameter Trace 1
Mean 22.16 dBm
Peak 25.78 dBm
Crest 3.62 dB

10 % 1.76 dB
1 % 2.64 dB
.1 % 3.16 dB
.01 % 3.40 dB

Date: 16.OCT.2017 09:55:07

Middle channel

UMTS 1900 RMC



Date: 16.OCT.2017 09:58:14



6.4 Modulation Characteristic

According to FCC § 2.1047(d), Part 22H & 24E & 27L there is no specific requirement for digital modulation, therefore modulation characteristic is not presented.

6.5 Out of band emission at antenna terminals

Test Requirement:	FCC part 22.917(a), FCC part 24.238(a) and FCC Part 27.53 (h)	
Test Method:	ANSI/TIA-603-D 2010	
Limit:	-13dBm	
Test setup:	System simulator Splitter ATT EUT Spectrum Analyzer	
Test Procedure:	 The RF output of the transceiver was connected to a spectrum analyzer through appropriate attenuation. The resolution bandwidth of the spectrum analyzer was set at 100 kHz when below 1GHz, 1MHz when above 1 GHz; sufficient scans were taken to show the out of band Emissions if any up to 10th harmonic. For the out of band: Set the RBW=100 kHz, VBW=300 kHz when below 1 GHz, RBW =1 MHz, VBW=3 MHz when above 1 GHz, Start=30MHz, Stop= 10th harmonic. Band Edge Requirements: In the 1 MHz bands immediately outside and adjacent to the frequency block, a resolution bandwidth of at least 1 percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to measure the out of band Emissions. 	
Test Instruments:	Refer to section 5.8 for details	
Test mode:	Refer to section 5.3 for details	
Test results:	Passed	

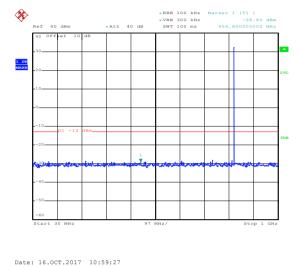


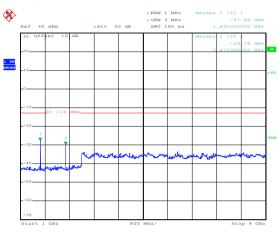
Test plots as follows:

Spurious emission:

GSM 850

Lowest Channel

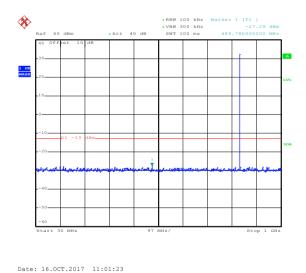


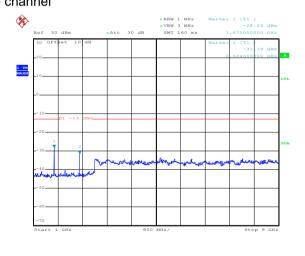


30MHz~1GHz

1GHz~9GHz

Middle channel





Date: 16.0CT.2017 10:57:46

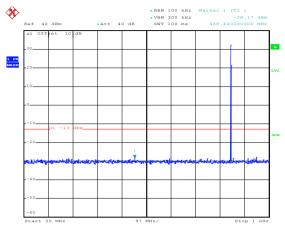
Date: 16.0CT.2017 10:57:26

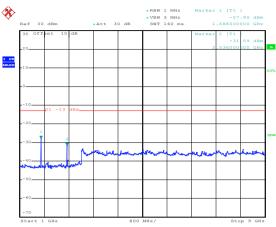
30MHz~1GHz

1GHz~9GHz



Highest Channel





Date: 16.OCT.2017 10:59:01

30MHz~1GHz

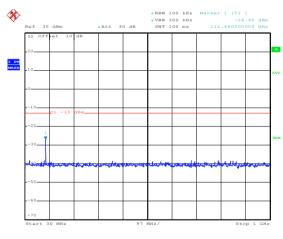
1GHz~9GHz

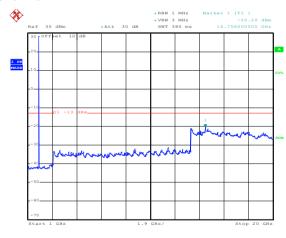
PCS 1900

Date: 16.0CT.2017 10:58:16

Date: 16.0CT.2017 10:40:30

Lowest Channel





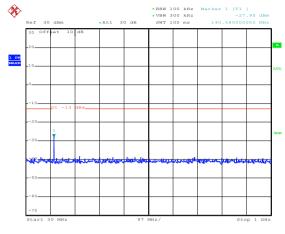
Date: 16.OCT.2017 10:37:44

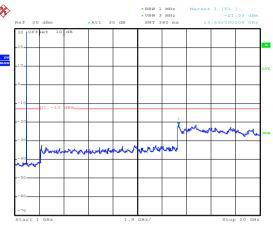
30MHz~1GHz

1GHz~20GHz



Middle Channel





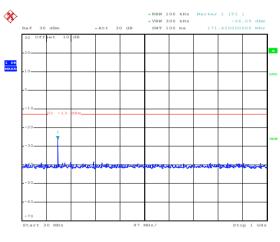
Date: 16.0CT.2017 10:37:58

30MHz~1GHz

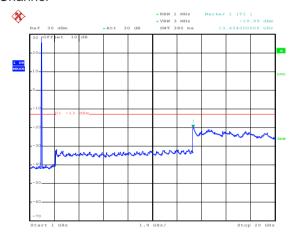
1GHz~20GHz

Highest Channel

Date: 16.0CT.2017 10:40:56



30MHz~1GHz



Date: 16.0CT.2017 10:38:14

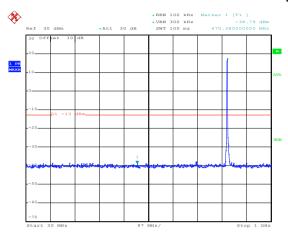
Date: 16.OCT.2017 10:56:09

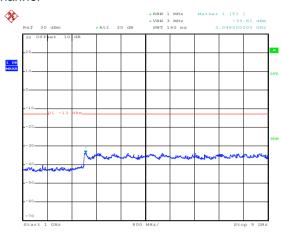
1GHz~20GHz



UMTS 850 12.2k RMC

Lowest Channel





Date: 16.0CT.2017 11:06:29

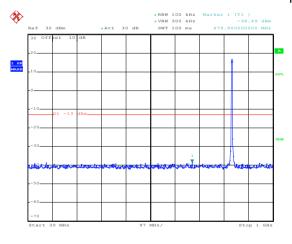
30MHz~1GHz

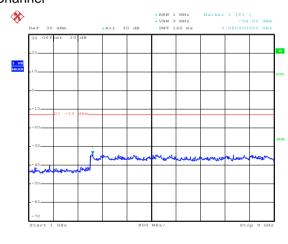
1GHz~9GHz

Middle Channel

Date: 16.0CT.2017 11:08:05

Date: 16.0CT.2017 11:08:21



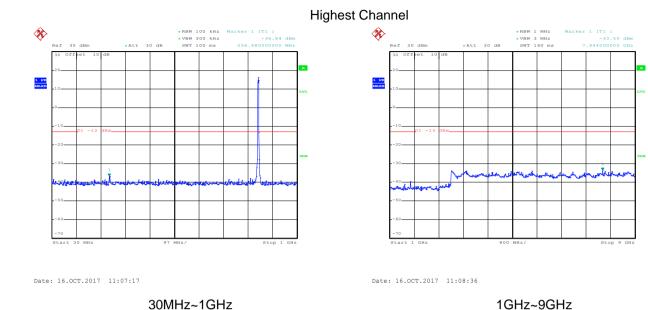


Date: 16.0CT.2017 11:06:49

30MHz~1GHz

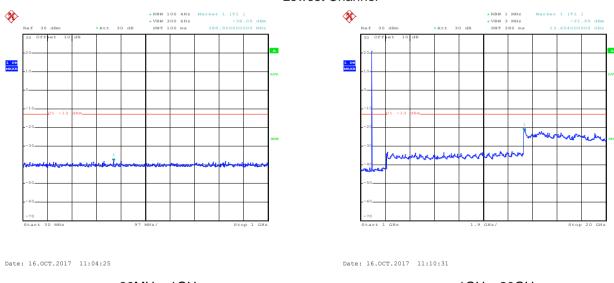
1GHz~9GHz





UMTS 1900 12.2k RMC

Lowest Channel

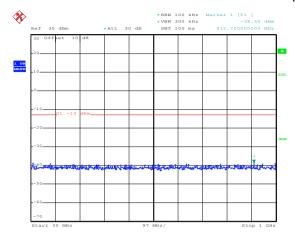


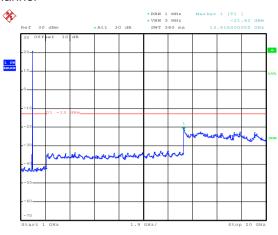
30MHz~1GHz 1GHz~20GHz





Middle Channel





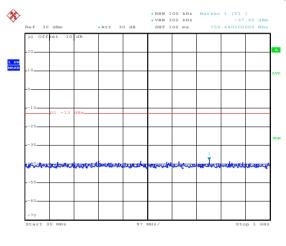
Date: 16.0CT.2017 11:04:36

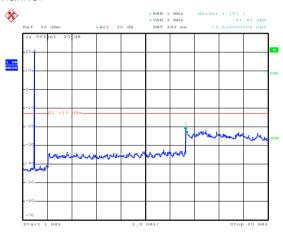
30MHz~1GHz

1GHz~20GHz

Highest Channel

Date: 16.0CT.2017 11:10:56





Date: 16.0CT.2017 11:04:48

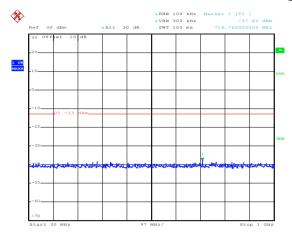
Date: 16.0CT.2017 11:11:21 30MHz~1GHz

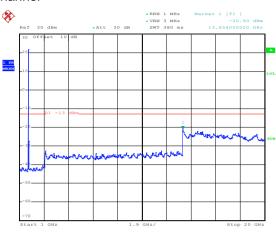
1GHz~20GHz



UMTS 1700 12.2k RMC

Lowest Channel





Date: 16.0CT.2017 11:05:15

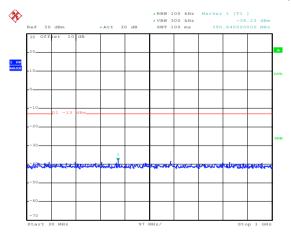
30MHz~1GHz

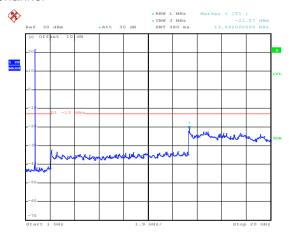
1GHz~20GHz

Middle Channel

Date: 16.0CT.2017 11:09:19

Date: 16.0CT.2017 11:09:37





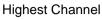
Date: 16.0CT.2017 11:05:26

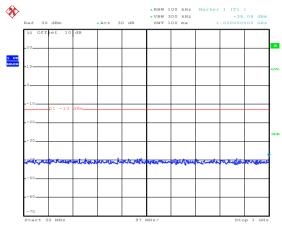
30MHz~1GHz

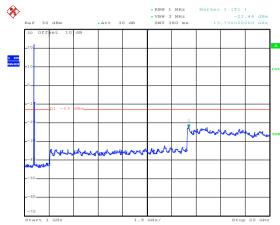
1GHz~20GHz









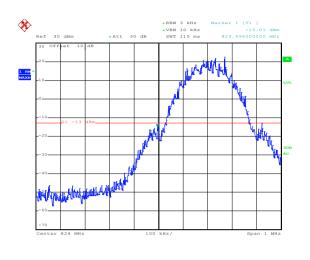


Date: 16.0CT.2017 11:05:37 Date: 16.0CT.2017 11:09:54

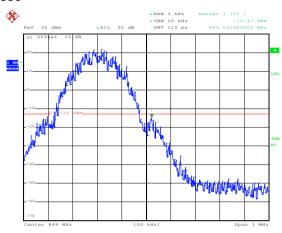
30MHz~1GHz 1GHz~20GHz



Band edge emission:



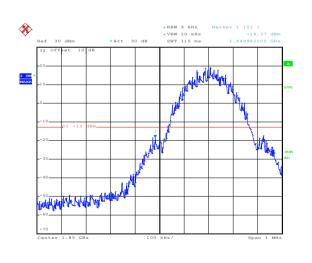
GSM850



Date: 16.0CT.2017 10:08:48

Lowest channel

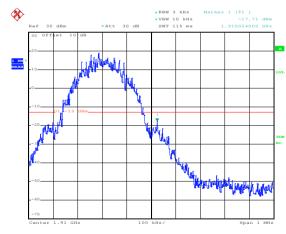
Highest channel



PCS1900

Date: 16.0CT.2017 10:09:07

Date: 16.0CT.2017 10:11:43



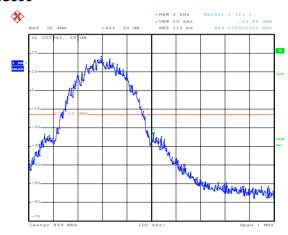
Date: 16.0CT.2017 10:10:27

Lowest channel

Highest channel



EGPRS850

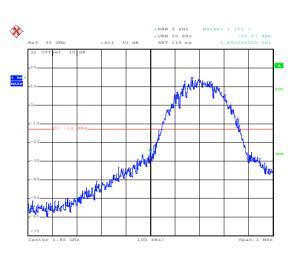


Date: 16.OCT.2017 10:02:53

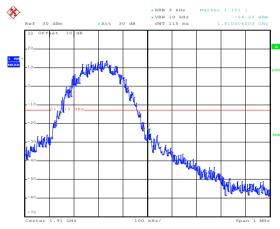
Lowest channel

Date: 16.0CT.2017 10:03:45

Highest channel







Date: 16.OCT.2017 11:24:40

Lowest channel

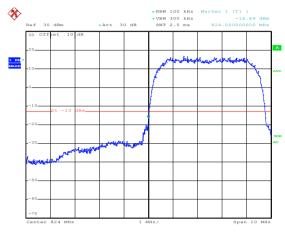
Date: 16.0CT.2017 11:25:05

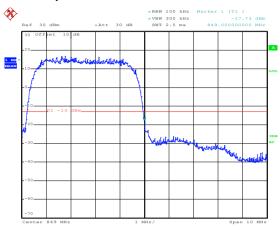
Highest channel

_



UMTS 850 RMC 12.2kbps





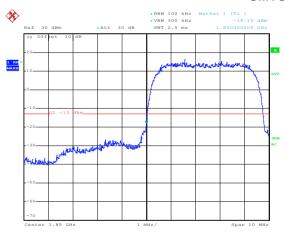
Date: 16.0CT.2017 09:42:58

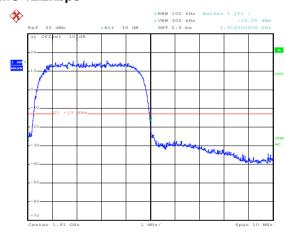
Date: 16.0CT.2017 09:43:16

Lowest channel

Highest channel

UMTS 1900 RMC 12.2kbps





Date: 16.0CT.2017 09:43:48

Date: 16.0CT.2017 09:44:07

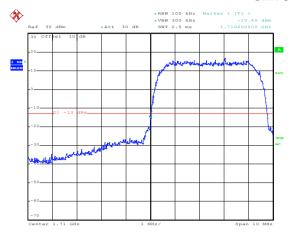
Lowest channel

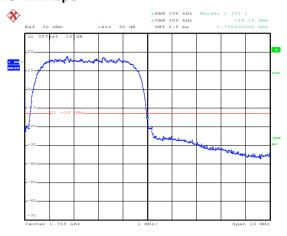
Highest channel





UMTS 1700 RMC 12.2kbps





Lowest channel

Date: 16.0CT.2017 09:44:39

Date: 16.0CT.2017 09:52:52

Highest channel



6.6 ERP, EIRP Measurement

6.6 ERP, EIRP Measure	
Test Requirement:	FCC part 22.913(a)(2), FCC part 24.232(c) and FCC part 27.50(d)(4)
Test Method:	ANSI/TIA-603-D 2010
Limit:	GSM850 7W: ERP, PCS1900 2W: EIRP
	UMTS 850: 7W ERP, UMTS1900: 2W EIRP, UMTS1700: 1W EIRP
Test setup:	Below 1GHz
	Antenna Tower Antenna Tower Ground Reference Plane
	Above 1GHz
	Horn Antenna Tower Antenna Tower
Test Procedure:	1. The EUT was placed on an non-conductive turntable using a non-
Test Instruments:	conductive support. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and EMI spectrum analyzer. 2. During the measurement, the EUT was communication with the station. The highest emission was recorded with the rotation of the turntable and the lowering of the test antenna from 4m to 1m. The reading was recorded and the field strength (E in dBuV/m) was calculated. 3. ERP in frequency band 824.2 –848.80.8MHz were measured using a substitution method. The EUT was replaced by dipole antenna connected, the S.G. output was recorded and ERP was calculated as follows: ERP = S.G. output (dBm) + Antenna Gain (dBd) – Cable Loss (dB) 4. EIRP in frequency band 1850.2 –1909.8MHz were measured using a substitution method. The EUT was replaced by or horn antenna connected, the S.G. output was recorded and EIRP was calculated as follows: EIRP = S.G. output (dBm) + Antenna Gain (dBi) – Cable Loss (dB) 5. The worse case was relating to the conducted output power. Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed





Measurement Data (worst case):

EUT mode	Channel	EUT Pol.	Antenna Pol.	ERP(dBm)	Limit (dBm)	Result
CCMOEO	100	Ш	V	23.76		
GSM850	128	Н	Н	25.86		
EGPRS 850	100	Ш	V	16.65	20.45	Door
EGPRS 650	128	Н	Н	20.96	38.45	Pass
UMTS 850 12.2k	4400	Ш	V	20.67		
RMC	4183	Н	Н	22.22		

EUT mode	Channel	EUT Pol.	Antenna Pol.	EIRP(dBm)	Limit (dBm)	Result
PCS1900	940	Ш	V	19.79		
PC51900	810	Н	Н	16.19		
ECDDC 4000	540	1.1	V	13.58	22	Daga
EGPRS 1900	512	Н	Н	12.43	33	Pass
UMTS 1900	0000	1.1	V	15.82		
12.2k RMC	9262	Н	Н	16.55		

EUT mode	Channel	EUT Pol.	Antenna Pol.	EIRP(dBm)	Limit (dBm)	Result
UMTS 1700	1513	Н	V	14.95	30.00	Pass
12.2k RMC	1313	П	Н	17.37	30.00	Pass



6.7 Field strength of spurious radiation measurement

Test Requirement:	FCC part 22.917(a), FCC part 24.238(a) and FCC part 27.53(h)
Test Method:	ANSI/TIA-603-D 2010
Limit:	-13dBm
Limit: Test setup:	Below 1GHz Antenna Tower Test Receiver Antenna Tower Above 1GHz Ground Reference Plane
Test Procedure:	 The EUT was placed on an non-conductive turntable using a non-conductive support. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and EMI spectrum analyzer. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations. The frequency range up to tenth harmonic was investigated for each of three fundamental frequency (low, middle and high channels). Once spurious emission was identified, the power of the emission was determined using the substitution method. The spurious emissions attenuation was calculated as the difference between radiated power at the fundamental frequency and the spurious emissions frequency. ERP / EIRP = S.G. output (dBm) + Antenna Gain(dB/dBi) – Cable Loss (dB)
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details.
Test results:	Passed





Measurement Data (worst case):

Test mode:	GSN	1850	Test channel:	Lowest	
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result	
r requericy (Wir 12)	Polarization	Level (dBm)	Limit (dbin)	Nesuit	
1648.40	Vertical	-49.05			
2472.60	V	-44.40	-13.00	Pass	
3296.80	V	-54.70			
1648.40	Horizontal	-49.45			
2472.60	Н	-46.04	-13.00	Pass	
3296.80	Н	-50.91			
Test mode:	GSN	1850	Test channel:	Middle	
Frequency (MHz)	Spurious	Emission	Line it (dDan)	Doort	
1 roquonoy (IVII 12)	Polarization	Level (dBm)	Limit (dBm)	Result	
1673.20	Vertical	-46.71			
2509.80	V	-44.92	-13.00	Pass	
3346.40	V	-53.79			
1673.20	Horizontal	-45.90			
2509.80	Н	-39.80	-13.00	Pass	
3346.40	Н	-52.53			
Test mode:	GSN	1850	Test channel:	Highest	
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result	
1 requeries (IVII 12)	Polarization	Level (dBm)	Limit (dbin)	rtosuit	
1697.60	Vertical	-49.41			
2546.40	V	-48.23	-13.00	Pass	
3395.20	V	-54.16			
1697.60	Horizontal	-44.01			
2546.40	Н	-44.27	-13.00	Pass	
3395.20	Н	-52.54			

Remark:

1. The emission levels of below 1 GHz are very lower than the limit and not show in test report.





Test mode:	PCS	1900	Test channel:	Lowest	
Fraguency (MUz)	Spurious	Emission	Limit (dPm)	Result	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
3700.40	Vertical	-45.40	-13.00	Pass	
5550.60	V	-45.35	-13.00	rass	
3700.40	Horizontal	-48.03	-13.00	Pass	
5550.60	Н	-45.29	-13.00	F a55	
Test mode:	PCS	1900	Test channel:	Middle	
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result	
Frequency (IVII 12)	Polarization	Level (dBm)	Limit (dbin)	Result	
3760.00	Vertical	-46.89	-13.00	Pass	
5640.00	V	-43.93	-13.00	F a55	
3760.00	Horizontal	-52.37	-13.00	Pass	
5640.00	Н	-46.63	-13.00	1 033	
Test mode:	PCS	1900	Test channel:	Highest	
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result	
Frequency (IVII12)	Polarization	Level (dBm)	Limit (dBin)	Result	
3819.60	Vertical	-50.54	-13.00	Pass	
5729.40	V	-42.71	-13.00	газэ	
3819.60	Horizontal	-51.54	-13.00	Pass	
5729.40	Н	-45.20	-13.00	Fass	

1. The emission levels of below 1 GHz are very lower than the limit and not show in test report.





Test mode:	WCDMA BAND V 12.2k RMC		Test channel:	Lowest	
Fraguency (MUz)	Spurious	Emission	Limit (dBm) Result		
Frequency (MHz)	Polarization	Level (dBm)	Lillill (dbill)	Nesult	
1652.80	Vertical	-50.71			
2479.20	V	-38.28	-13.00	Pass	
3305.60	V	-50.73			
1652.80	Horizontal	-49.74			
2479.20	Н	-43.11	-13.00	Pass	
3305.60	Н	-53.06			
Test mode:	WCDMA BANI	O V 12.2k RMC	Test channel:	Middle	
Fraguenov (MHz)	Spurious	Emission	Limit (dPm)	Popult	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
1673.20	Vertical	-53.00			
2509.80	V	-37.21	-13.00	Pass	
3346.40	V	-52.28			
1673.20	Horizontal	-54.11			
2509.80	Н	-35.11	-13.00	Pass	
3346.40	Н	-53.20			
Test mode:	WCDMA BANI	O V 12.2k RMC	Test channel:	Highest	
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result	
r requericy (ivii iz)	Polarization	Level (dBm)	Limit (dbin)	Nesuit	
1693.20	Vertical	-55.67			
2539.80	V	-40.62	-13.00	Pass	
3386.40	V	-55.19			
1693.20	Horizontal	-55.30			
2539.80	Н	-41.15	-13.00	Pass	
3386.40	Н	-54.72			

^{1.} The emission levels of below 1 GHz are very lower than the limit and not show in test report.





Test mode:	WCDMA Band II 12.2k RMC		Test channel:	Lowest	
Frequency (MHz)	Spurious	Emission	Limit (dBm) Result		
Frequency (MHZ)	Polarization	Level (dBm)	Limit (dBm)	Result	
3704.80	Vertical	-51.09			
5557.20	V	-45.41	-13.00	Pass	
3704.80	Horizontal	-48.69		F 455	
5557.20	Н	-47.67			
Test mode:	WCDMA Band	l II 12.2k RMC	Test channel:	Middle	
Eroguenov (MHz)	Spurious	Emission	Limit (dPm)	Result	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Kesuit	
3760.00	Vertical	-51.50			
5640.00	V	-46.77	-13.00	Pass	
3760.00	Horizontal	-49.97		F 455	
5640.00	Н	-45.32			
Test mode:	WCDMA Band	l II 12.2k RMC	Test channel:	Highest	
	Spurious	Emission			
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
3815.20	Vertical	-50.17			
5722.80	V	-44.20		_	
3815.20	Horizontal	-51.31	-13.00	Pass	
5722.80	Н	-47.87			

1. The emission levels of below 1 GHz are very lower than the limit and not show in test report.





Test mode:	UMTS 1700	12.2k RMC	Test channel:	Lowest	
Fraguera (MIII-)	Spurious	Emission	Limit (dDay)		
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
3424.40	Vertical	-52.62			
5136.60	V	-45.55	42.00	Dana	
3424.40	Horizontal	-51.19	-13.00	Pass	
5136.60	Н	-46.85			
Test mode:	UMTS 1700	12.2k RMC	Test channel:	Middle	
Fraguera (MIII-)	Spurious	Emission	Limeit (dDms)	Decult	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
3464.80	Vertical	-53.16			
5197.20	V	-45.76	40.00	Descri	
3464.80	Horizontal	-52.72	-13.00	Pass	
5197.20	Н	-44.41			
Test mode:	UMTS 1700	12.2k RMC	Test channel:	Highest	
	Spurious	Emission	Limit (dDm)	Danilt	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
3505.20	Vertical	-51.74			
5257.80	V	-44.00	40.00	Dana	
3505.20	Horizontal	-49.64	-13.00	Pass	
5257.80	Н	-42.94			

1. The emission levels of below 1 GHz are very lower than the limit and not show in test report.



6.8 Frequency stability V.S. Temperature measurement

Test Requirement:	FCC Part 22.355, FCC Part 24.235, FCC Part 27.54, FCC Part 2.1055(a)(1)(b)
Test Method:	ANSI/TIA-6-3-D 2010
Limit:	±2.5 ppm
Test setup:	SS Divider Temperature & Humidity Chamber Power Source
Test procedure:	 The equipment under test was connected to an external DC power supply and input rated voltage. RF output was connected to a frequency counter or spectrum analyzer via feed through attenuators. The EUT was placed inside the temperature chamber. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and measure EUT 25°C operating frequency as reference frequency. Turn EUT off and set the chamber temperature to -30°C. After the temperature stabilized for approximately 30 minutes recorded the frequency. Repeat step measure with 10°C increased per stage until the highest temperature of +50°C reached
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed





Measurement Data (the worst channel):

Reference Frequency: GSM850 Middle channel=190 channel=836.6MHz					
Power supplied	Temperature (°C)	Freq	uency error	Limit (ppm)	Result
(Vdc)	Temperature (C)	Hz	ppm	Limit (ppm)	Kesuit
	-30	199	0.237868		
	-20	163	0.194836		
	-10	135	0.161367]	
	0	120	0.143438		
3.80	10	141	0.168539	±2.5	Pass
	20	171	0.204399		
	30	180	0.215157		
	40	164	0.196032		
	50	109	0.130289		
Re	ference Frequency: P0	CS1900 Middle	channel=661 chann	el=1880MHz	
Power supplied	Tomporature (°C)	Frequency error			Dogult
(Vdc)	Temperature (°C)	Hz	ppm	Limit (ppm)	Result
	-30	188	0.100000		
	-20	179	0.095213		
	-10	169	0.089894		
	0	123	0.065426		
3.80	10	136	0.072340	±2.5	Pass
	20	150	0.079787		
	30	142	0.075532		
	40	107	0.056915		
	50	117	0.062234		

Note: Only the worst case shown in the report.





Reference Frequency: EGPRS850 Middle channel=190 channel=836.6MHz						
Power supplied (Vdc)	Temperature (°C)	Frequ	uency error	Limit (ppm)	Result	
		Hz	ppm	Limit (ppm)		
	-30	196	0.234282		Pass	
	-20	181	0.216352			
	-10	123	0.147024			
	0	136	0.162563			
3.80	10	141	0.168539	±2.5		
	20	170	0.203203			
	30	178	0.212766			
	40	106	0.126703			
	50	168	0.200813			
Refere	Reference Frequency: EGPRS 1900 Middle channel=661 channel=18					
Power supplied	Tomporature (°C)	Frequency error		Limit (ppm)	Result	
(Vdc)	Temperature (°C)	Hz	ppm	Limit (ppin)	Result	
	-30	180	0.095745	±2.5	Pass	
	-20	123	0.065426			
	-10	136	0.072340			
3.80	0	171	0.090957			
	10	147	0.078191			
	20	130	0.069149			
	30	104	0.055319			
	40	149	0.079255			
	50	159	0.084574			

Note: Only the worst case shown in the report.





Reference Fre	equency: WCDMA BAN	ND V 12.2k	RMC Middle channel=4	1183 channel=83	6.6MHz
Power supplied	Towns and the (°C)	Frequency error			
(Vdc)	Temperature (°C)	Hz	ppm	Limit (ppm)	Result
	-30	199	0.237868		Pass
	-20	180	0.215157		
	-10	171	0.204399		
	0	160	0.191250		
3.80	10	131	0.156586	±2.5	
	20	141	0.168539		
	30	108	0.129094	1	
	40	150	0.179297		
	50	126	0.150610	1	
Reference Fre	equency: WCDMA BA	ND II 12.2k	RMC Middle channel=9	9400 channel=18	80MHz
Power supplied	Temperature (°C)	Frequency error		Limit (nnm)	Pocult
(Vdc)	remperature (C)	Hz	ppm	Limit (ppm)	Result
	-30	198	0.105319	±2.5	Pass
	-20	165	0.087766		
	-10	181	0.096277		
	0	171	0.090957		
3.80	10	123	0.065426		
	20	134	0.071277		
	30	108	0.057447		
	40	116	0.061702		
	50	100	0.053191		
Reference I	Frequency: UMTS170	0 12.2k RM0	C Middle channel=1413	3 channel=1732.6	SMHz
Power supplied	Tomporoture (°C)	Frequency error		Limit (nnm)	Result
(Vdc)	Temperature (°C)	Hz	ppm	Limit (ppm)	Result
	-30	198	0.114279	±2.5 P	
3.80	-20	171	0.098696		
	-10	180	0.103890		
	0	165	0.095233		Pass
	10	132	0.076186		
	20	144	0.083112		
	30	108	0.062334		
	40	116	0.066951		
	50	148	0.085421		

Note: Only the worst case shown in the report.



6.9 Frequency stability V.S. Voltage measurement

Test Requirement:	FCC Part 22.355, FCC Part 24.235, FCC Part 27.54, FCC Part 2.1055(d)(2)
Test Method:	ANSI/TIA-603-D 2010
Limit:	±2.5ppm
Test setup:	SS Divider Temperature & Humidity Chamber Power Source
Test procedure:	 Set chamber temperature to 25°C. Use a variable DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency. Reduce the input voltage to specify extreme voltage variation (+/-15%) and endpoint, record the maximum frequency change.
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed





Measurement Data (the worst channel):

Measurement Data (ti	ie worst channel).					
Ref	ference Frequency: 0	SSM850 Middle ch	annel=190 chann	el=836.6MHz		
Temperature (°C)	Power supplied	Frequency error		Limit (ppm)	Result	
- ()	(Vdc)	Hz	ppm	сини (ррии)	Nesuit	
	4.35	99	0.118336			
25	3.80	81	0.096820	±2.5	Pass	
	3.50	65	0.077695			
Ref	ference Frequency: F	CS1900 Middle cl	hannel=661 chann	el=1880MHz		
Tomporature (°C)	Power supplied	Frequency error		Limeit (mmma)	Decul	
Temperature (°C)	(Vdc)	Hz	ppm	Limit (ppm)	Result	
	4.35	90	0.047872	±2.5	Pass	
25	3.80	84	0.044681			
	3.50	72	0.038298			
Refe	rence Frequency: EG	PRS 850 Middle o	channel= 190 char	nel=836.6MHz		
T (%C)	Power supplied	Frequency error		Limit (none)	Decult	
Temperature (°C)	(Vdc)	Hz	ppm	Limit (ppm)	Result	
	4.35	68	0.081281			
25	3.80	78	0.093235	±2.5	Pass	
	3.50	90	0.107578			
Reference Frequency: EGPRS 1900 Middle channel= 661 channel=1880MHz						
Temperature (°C)	Power supplied	ver supplied Frequency error		Limit (nnm)	Dogult	
	(Vdc)	Hz	ppm	Limit (ppm)	Result	
	4.35	96	0.051064			
25	3.80	80	0.042553	±2.5	Pass	
	3.50	75	0.039894			

Note: Only the worst case shown in the report.





Reference	Frequency: UMTS 8	350 12.2k RMC Mic	ddle channel=418	3 channel=836.6N	ИНz	
Temperature (℃)	Power supplied	Frequency error		Limit (ppm)	Result	
	(Vdc)	Hz	ppm	(F F····)		
	4.35	98	0.117141			
25	3.80	86	0.102797	±2.5	Pass	
	3.50	71	0.084867			
Reference Frequency: UMTS 1900 12.2k RMC Middle channel=9400 channel=1880MHz						
T(%C)	Power supplied	Frequency error			5	
Temperature (°C)	(Vdc)	Hz	ppm	Limit (ppm)	Result	
	4.35	85	0.045213			
25	3.80	94	0.050000	±2.5	Pass	
	3.50	70	0.037234			
Reference Frequency: UMTS1700 12.2k RMC Middle channel=1413 channel=1732.6MHz						
Temperature ($^{\circ}$)	Power supplied	Frequency error		Limit (nnm)	Dogult	
	(Vdc)	Hz	ppm	Limit (ppm)	Result	
	4.35	99	0.057140			
25	3.80	80	0.046173	2.5	Pass	
	3.50	64	0.036939			